

Notice of References Cited	Application/Control No. 10/080,729		Applicant(s)/Patent Under Reexamination EYER, MARK KENNETH	
	Examiner ALBERT T. CHOU		Art Unit 2416	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0201390	09-2005	Kikuchi, Takayuki	370/395.64
	B	US-			
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	D	US-			
	E	US-			
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FOREIGN PATENT DOCUMENTS

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